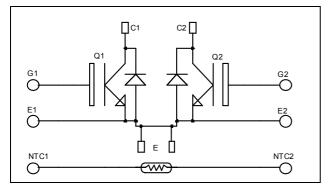


### Dual common source Trench + Field Stop IGBT3 Power Module



# APTGT100DU60TG

### $V_{CES} = 600V$ $I_{C} = 100A$ @ Tc = 80°C

#### Application

- AC Switches
- Switched Mode Power Supplies
- Uninterruptible Power Supplies

#### Features

- Trench + Field Stop IGBT3 Technology
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 20 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Very low stray inductance
  - Symmetrical design
  - Lead frames for power connections
- High level of integration
- Internal thermistor for temperature monitoring

#### Benefits

- Stable temperature behavior
- Very rugged
- Solderable terminals for easy PCB mounting
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of VCEsat
- Low profile
- RoHS Compliant

### Absolute maximum ratings

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0

Λ

Symbol	Parameter		Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Breakdown Voltage		600	V
Т	Continuous Collector Current	$T_C = 25^{\circ}C$	150	
I <sub>C</sub>	Continuous Conector Current	$T_C = 80^{\circ}C$	100	А
I <sub>CM</sub>	Pulsed Collector Current	$T_C = 25^{\circ}C$	200	
V <sub>GE</sub>	Gate – Emitter Voltage		±20	V
PD	Maximum Power Dissipation	$T_C = 25^{\circ}C$	340	W
RBSOA	Reverse Bias Safe Operating Area	$T_j = 150^{\circ}C$	200A @ 550V	

0

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

G2 🖡

E2 👔

C2



### All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit	
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} =$			250	μA	
V <sub>CE(sat)</sub>	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		1.5	1.9	V
V CE(sat)		$I_{\rm C} = 100 {\rm A}$ $T_{\rm j} = 150^{\circ} {\rm C}$	$T_{j} = 150^{\circ}C$		1.7		v
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 1.5 \text{ mA}$		5.0	5.8	6.5	V
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				400	nA

### **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$		6100		
Coes	Output Capacitance	$V_{CE} = 25V$		390		pF
C <sub>res</sub>	Reverse Transfer Capacitance	f = 1 MHz		190		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (25°C)		115		
T <sub>r</sub>	Rise Time	$V_{GE} = \pm 15V$		45		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 300V$ $I_C = 100A$		225		ns
$T_{\rm f}$	Fall Time	$R_G = 3.3\Omega$		55		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (150°C	<sup>(</sup> )	130		
Tr	Rise Time	$V_{GE} = \pm 15V$		50		
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 300V$ $I_{C} = 100A$		300		ns
$T_{f}$	Fall Time	$R_G = 3.3\Omega$		70		
Б	Turn on Energy	$V_{GE} = \pm 15V$ $T_j = 25^{\circ}C$		0.4		mJ
Eon	Turn on Energy	$V_{Bus} = 300V$ $T_j = 150^{\circ}C$		0.875		IIIJ
Б	Turn off Energy	$I_{\rm C} = 100 {\rm A}$ $T_{\rm j} = 25^{\circ} {\rm C}$		2.5		mJ
E <sub>off</sub>		$R_G = 3.3\Omega \qquad T_j = 150^{\circ}C$		3.5		IIIJ

#### **Reverse diode ratings and characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			600			V
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =600V	$T_i = 25^{\circ}C$ $T_i = 150^{\circ}C$			250 500	μΑ
I <sub>F</sub>	DC Forward Current		$Tc = 80^{\circ}C$		100		А
V_	$V_{\rm F}$ Diode Forward Voltage $I_{\rm F} = 100 \text{A}$ $V_{\rm GE} = 0 \text{V}$	$I_{\rm F} = 100 {\rm A}$	$T_i = 25^{\circ}C$		1.6	2	V
▼ F		$T_{i} = 150^{\circ}C$		1.5		v	
t <sub>rr</sub>	Reverse Recovery Time	$T_i = 150$	$T_j = 25^{\circ}C$		125		ns
ι <sub>rr</sub>			$T_j = 150^{\circ}C$		220		115
0	Reverse Recovery Charge	$I_F = 100A$ $V_R = 300V$ $di/dt = 2000A/\mu s$	$T_j = 25^{\circ}C$		4.7		чС
Q <sub>rr</sub>			$T_{i} = 150^{\circ}C$		9.9		μC
Б	Reverse Recovery Energy		$T_j = 25^{\circ}C$		1.1		mI
Er			$T_{j} = 150^{\circ}C$		2.4		mJ



# APTGT100DU60TG

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

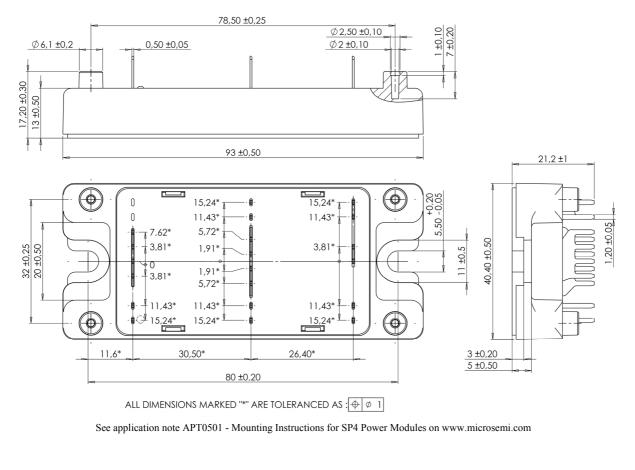
Symbol	Characteristic	Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		50		kΩ
B 25/85	$T_{25} = 298.15 \text{ K}$		3952		K
	$R_{-} = \frac{R_{25}}{1}$ T: Thermistor temperature				

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature  
R<sub>T</sub>: Thermistor value at T

Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit
R <sub>thJC</sub>	Junction to Case Thermal Resistance		IGBT			0.44	°C/W
			Diode	e		0.77	C/ w
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
T <sub>J</sub>	Operating junction temperature range		-40		175		
T <sub>STG</sub>	Storage Temperature Range		-40		125	°C	
T <sub>C</sub>	Operating Case Temperature			-40		100	
Torque	Mounting torque	To Heatsink	M5	2.5		4.7	N.m
Wt	Package Weight					160	g

#### SP4 Package outline (dimensions in mm)



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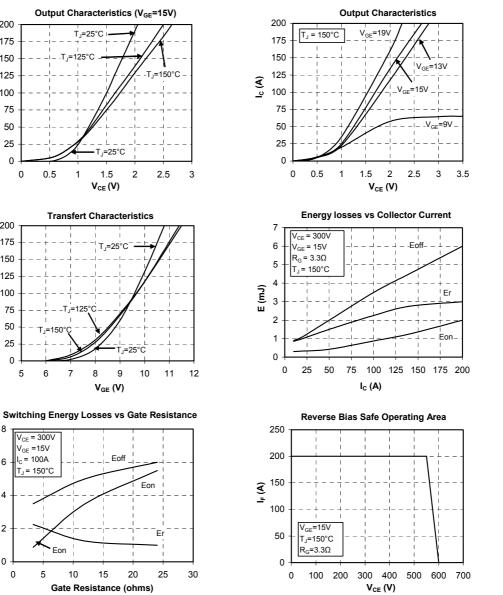


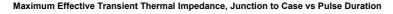
#### **Typical Performance Curve**

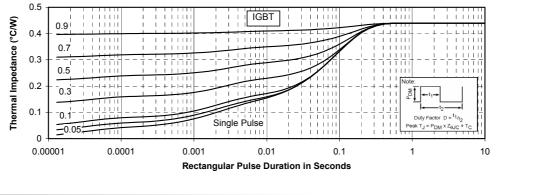
E (mJ)

I<sub>c</sub> (A)

I<sub>c</sub> (A) 







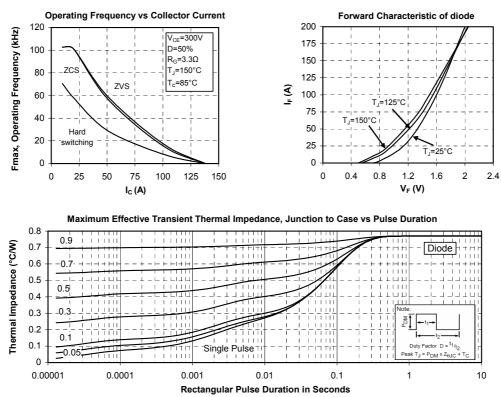
APTGT100DU60TG-Rev 2 October, 2012

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